

Notice of References Cited

Application/Control No.

10/537,786

Applicant(s)/Patent Under
Reexamination
FUTAMATA, HIROMASA

Examiner

Dieu Hien T. Duong

Art Unit

2821

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0008146	01-2004	Ikegaya et al.	343/767
*	B	US-6,452,554	09-2002	Aoyama et al.	343/702
*	C	US-2004/0046697	03-2004	Tai et al.	343/700.0MS
*	D	US-6,124,831	09-2000	Rutkowski et al.	343/700MS
*	E	US-6,297,779	10-2001	Tsai, Szu-Nan	343/702
*	F	US-6,774,853	08-2004	Wong et al.	343/700MS
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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